Se	earch l	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/680,475	WONG ET AL.
Examiner	Art Unit
Quynh H. Nguyen	2614

SEARCHED				
Class	Subclass	Date	Examiner	
379	330 322 413	9/21/2007	QN	
above	updated	1/23/2008	QN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
379	330 322 413	1/23/2008	QN
Interference searched history printout		1/23/2008	QN

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY))
	DATE	EXMR
searched: East, USPGPub, USPAT, JPO, EPO	9/21/2007	QN
Inventor searched in PALM	9/21/2007	QN
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